Search Notes

Application/Control No.				
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Applicant(s)/Pat Reexamination	ent unde	r
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Examiner
Young J. Kim

HANNA, MICHELLE M.

Art Unit 1637

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SEARCH NOT (INCLUDING SEARCH)
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Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) see enclosed for text-search strategy	10/24/2006	YJK
PALM inventor name search	10/24/2006	YJK
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